Application/Control No. Applicant(s)/Patent Under Reexamination 10/619,652 LUCAS ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Ted Kavanaugh 3728 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-2003/0000109 A1 01-2003 36/30.00R Kita, Kenjiro Α 36/114 US-5,367,792 A 11-1994 Richard et al. В 36/30R

Shin, Yoon K.

Derderian et al.

Wezel et al.

Cohen, Eli

Kim, Sang D.

02-1985

08-1985

11-1986

07-1988

03-1993

	FOREIGN PATENT DOCUMENTS									
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification				
	N									
	0									
	Р									
	Q									
	R									
	S				·					
	Т									

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	_
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- 11	х		

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

US-4,498,251

US-4,535,553

US-4,624,061 US-4,754,559

US-5,195,256 A

US-

US-US-US-

US-US-

С

D

Ε

F

G

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Κ

М

36/28

36/30A

36/3B

36/27